

Description

The 9ZML1233E / 9ZML1253E are second generation enhanced performance DB1200ZL derivatives. The parts are pin-compatible upgrades to the 9ZML1232B, while offering much improved phase jitter performance. A fixed external feedback maintains low drift for critical QPI/UPI applications, while each input channel has software adjustable input-to-output delay to ease transport delay management for today's more complex server topologies. The 9ZML1233E and 9ZML1253E have an SMBus Write Lockout pin for increased device and system security.

PCIe Clocking Architectures Supported

- Common Clocked (CC)
- Independent Reference (IR) with and without spread spectrum

Typical Applications

- Servers
- Storage
- Networking
- SSDs

Output Features

- 12 Low-Power (LP) HCSL output pairs (1233E)
- 12 Low-Power (LP) HCSL output pairs with 85Ω Zout (1253E)

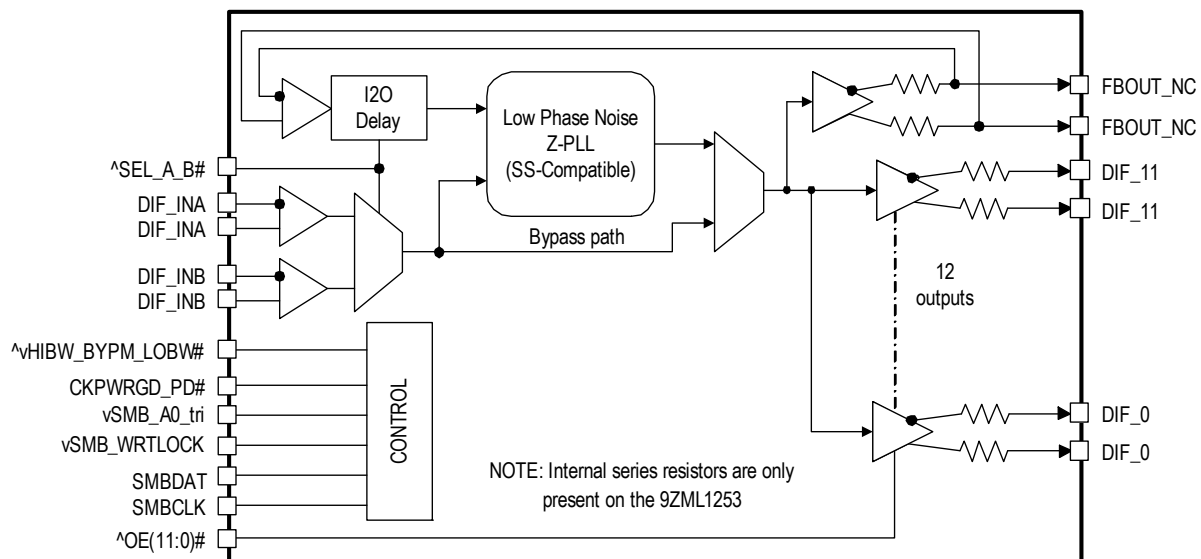
Features

- SMBus write lock feature; increases system security
- 2 software-configurable input-to-output delay lines; manage transport delay for complex topologies
- LP-HCSL outputs; eliminate 24 resistors, save 41mm² of area (1233E)
- LP-HCSL outputs with 85Ω Zout; eliminate 48 resistors, save 82mm² of area (1253E)
- 12 OE# pins; hardware control of each output
- 3 selectable SMBus addresses; multiple devices can share same SMBus segment
- Selectable PLL bandwidths; minimizes jitter peaking in cascaded PLL topologies
- Hardware/SMBus control of PLL bandwidth and bypass; change mode without power cycle
- Spread spectrum compatible; tracks spreading input clock for EMI reduction
- 100MHz PLL Mode; UPI support
- 10 x 10 mm 72-VFQFPN package; small board footprint

Key Specifications

- Cycle-to-cycle jitter < 50ps
- Output-to-output skew < 50ps
- Input-to-output delay: 0ps default
- Input-to-output delay variation < 50ps
- Phase jitter: PCIe Gen4 < 0.5ps rms
- Phase jitter: UPI > 9.6GB/s < 0.1ps rms
- Phase jitter: IF-UPI < 1.0ps rms

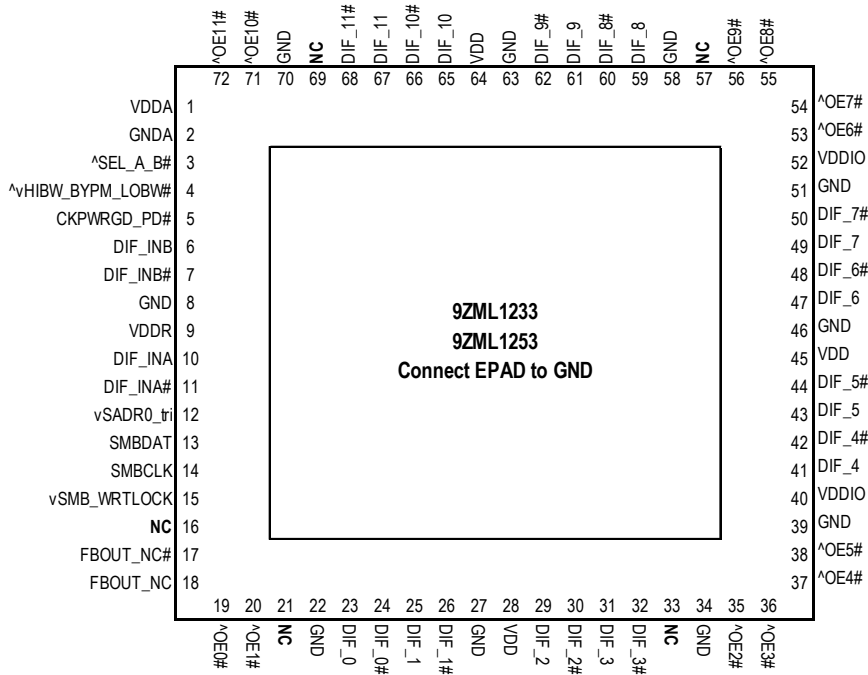
Block Diagram



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Pin Assignments



^ prefix indicates internal 120kohm pull-up
 v prefix indicates internal 120kohm pull-down
 10 x 10 mm 72-VFQFPN 0.5mm pin pitch

Pin Descriptions

Table 1. Pin Descriptions

Number	Name	Type	Description
1	V _{DDA}	Power	Power supply for PLL core.
2	GNDA	GND	Ground pin for the PLL core.
3	^SEL_A_B#	Input	Input to select differential input clock A or differential input clock B. This input has an internal 120kΩ pull-up resistor. 0 = input B selected, 1 = input A selected.
4	^vHIBW_BYPM_LOBW#	Latched In	Tri-level input to select High BW, Bypass or Low BW mode. This pin is biased to V _{DD} /2 (Bypass Mode) with internal pull-up/pull-down resistors. See <i>PLL Operating Mode</i> table for details.
5	CKPWRGD_PD#	Input	3.3V input notifies device to sample latched inputs and start up on first high assertion, or exit Power Down Mode on subsequent assertions. Low enters Power Down Mode.
6	DIF_INB	Input	True input of differential clock.
7	DIF_INB#	Input	Complement input of differential clock.
8	GND	GND	Ground pin.
9	V _{DDR}	Power	Power supply for differential input clock (receiver). This V _{DD} should be treated as an analog power rail and filtered appropriately. Nominally 3.3V.
10	DIF_INA	Input	True input of differential clock.
11	DIF_INA#	Input	Complement input of differential clock.

Table 1. Pin Descriptions (Cont.)

Number	Name	Type	Description
12	vSADR0_tri	Input	SMBus address bit. This is a tri-level input that works in conjunction with other SADR pins, if present, to decode SMBus Addresses. It has an internal 120kΩ pull-down resistor. See the <i>SMBus Addressing</i> table.
13	SMBDAT	I/O	Data pin of SMBUS circuitry.
14	SMBCLK	Input	Clock pin of SMBUS circuitry.
15	vSMB_WRTLOCK	Input	This pin prevents SMBus writes when asserted. SMBus reads are not affected. This pin has an internal 120kΩ pull-down. 0 = SMBus writes allows, 1 = SMBus writes blocked.
16	NC	—	No connection.
17	FBOUT_NC#	Output	Complementary half of differential feedback output. This pin should NOT be connected to anything outside the chip. It exists to provide delay path matching to get 0 propagation delay.
18	FBOUT_NC	Output	True half of differential feedback output. This pin should NOT be connected to anything outside the chip. It exists to provide delay path matching to get 0 propagation delay.
19	^OE0#	Input	Active low input for enabling output 0. This pin has an internal 120kΩ pull-up resistor. 1 = disable outputs, 0 = enable outputs.
20	^OE1#	Input	Active low input for enabling output 1. This pin has an internal pull-up resistor. 1 = disable outputs, 0 = enable outputs.
21	NC	—	No connection.
22	GND	GND	Ground pin.
23	DIF_0	Output	HCSL true clock output.
24	DIF_0#	Output	HCSL complementary clock output.
25	DIF_1	Output	HCSL true clock output.
26	DIF_1#	Output	HCSL complementary clock output.
27	GND	GND	Ground pin.
28	VDD	Power	Power supply, nominally 3.3V.
29	DIF_2	Output	HCSL true clock output.
30	DIF_2#	Output	HCSL complementary clock output.
31	DIF_3	Output	HCSL true clock output.
32	DIF_3#	Output	HCSL complementary clock output.
33	NC	—	No connection.
34	GND	GND	Ground pin.
35	^OE2#	Input	Active low input for enabling output 2. This pin has an internal pull-up resistor. 1 = disable outputs, 0 = enable outputs.
36	^OE3#	Input	Active low input for enabling output 3. This pin has an internal pull-up resistor. 1 = disable outputs, 0 = enable outputs.
37	^OE4#	Input	Active low input for enabling output 4. This pin has an internal pull-up resistor. 1 = disable outputs, 0 = enable outputs.

Table 1. Pin Descriptions (Cont.)

Number	Name	Type	Description
38	^OE5#	Input	Active low input for enabling output 5. This pin has an internal pull-up resistor. 1 = disable outputs, 0 = enable outputs.
39	GND	GND	Ground pin.
40	V _{DDIO}	Power	Power supply for differential outputs.
41	DIF_4	Output	HCSL true clock output.
42	DIF_4#	Output	HCSL complementary clock output.
43	DIF_5	Output	HCSL true clock output.
44	DIF_5#	Output	HCSL complementary clock output.
45	V _{DD}	PWR	Power supply, nominally 3.3V.
46	GND	GND	Ground pin.
47	DIF_6	Output	HCSL true clock output.
48	DIF_6#	Output	HCSL complementary clock output.
49	DIF_7	Output	HCSL true clock output.
50	DIF_7#	Output	HCSL complementary clock output.
51	GND	GND	Ground pin.
52	V _{DDIO}	Power	Power supply for differential outputs.
53	^OE6#	Input	Active low input for enabling output 6. This pin has an internal pull-up resistor. 1 = disable outputs, 0 = enable outputs.
54	^OE7#	Input	Active low input for enabling output 7. This pin has an internal pull-up resistor. 1 = disable outputs, 0 = enable outputs.
55	^OE8#	Input	Active low input for enabling output 8. This pin has an internal pull-up resistor. 1 = disable outputs, 0 = enable outputs.
56	^OE9#	Input	Active low input for enabling output 9. This pin has an internal pull-up resistor. 1 = disable outputs, 0 = enable outputs.
57	NC	—	No connection.
58	GND	GND	Ground pin.
59	DIF_8	Output	HCSL true clock output.
60	DIF_8#	Output	HCSL complementary clock output.
61	DIF_9	Output	HCSL true clock output.
62	DIF_9#	Output	HCSL complementary clock output.
63	GND	GND	Ground pin.
64	V _{DD}	Power	Power supply, nominally 3.3V.
65	DIF_10	Output	HCSL true clock output.
66	DIF_10#	Output	HCSL complementary clock output.
67	DIF_11	Output	HCSL true clock output.
68	DIF_11#	Output	HCSL complementary clock output.

Table 1. Pin Descriptions (Cont.)

Number	Name	Type	Description
69	NC	—	No connection.
70	GND	GND	Ground pin.
71	\wedge OE10#	Input	Active low input for enabling output 10. This pin has an internal pull-up resistor. 1 = disable outputs, 0 = enable outputs.
72	\wedge OE11#	Input	Active low input for enabling output 11. This pin has an internal pull-up resistor. 1 = disable outputs, 0 = enable outputs.
73	EPAD	GND	Connect to ground.

Absolute Maximum Ratings

Stresses above the ratings listed below can cause permanent damage to the 9ZML1233E / 9ZML1253E. These ratings, which are standard values for IDT commercially rated parts, are stress ratings only. Functional operation of the device at these or any other conditions above those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods can affect product reliability. Electrical parameters are guaranteed only over the recommended operating temperature range.

Table 2. Absolute Maximum Ratings

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units	Notes
Supply Voltage	V_{DDx}				3.9	V	1,2
Input Low Voltage	V_{IL}		GND-0.5			V	1
Input High Voltage	V_{IH}	Except for SMBus interface.			$V_{DD} + 0.5$	V	1,3
Input High Voltage	V_{IHSMB}	SMBus clock and data pins.			3.9	V	1
Storage Temperature	T_s		-65		150	°C	1
Junction Temperature	T_j				125	°C	1
Input ESD Protection	ESD prot	Human Body Model.	2000			V	1

¹ Guaranteed by design and characterization, not 100% tested in production.

² Operation under these conditions is neither implied nor guaranteed.

³ Not to exceed 3.9V.

Electrical Characteristics

Over specified temperature and voltage ranges unless otherwise indicated; see Test Loads for loading conditions.

Table 3. SMBus Parameters

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units	Notes
SMBus Input Low Voltage	V_{ILSMB}				0.8	V	
SMBus Input High Voltage	V_{IHSMB}		2.1		V_{DDSMB}	V	
SMBus Output Low Voltage	V_{OLSMB}	At I_{PULLUP} .			0.4	V	
SMBus Sink Current	I_{PULLUP}	At V_{OL} .	4			mA	
Nominal Bus Voltage	V_{DDSMB}		2.7		3.6	V	1

Table 3. SMBus Parameters (Cont.)

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units	Notes
SCLK/SDATA Rise Time	t_{RSMB}	(Max $V_{IL} - 0.15V$) to (Min $V_{IH} + 0.15V$).			1000	ns	1
SCLK/SDATA Fall Time	t_{FSMB}	(Min $V_{IH} + 0.15V$) to (Max $V_{IL} - 0.15V$).			300	ns	1
SMBus Operating Frequency	f_{MAXMB}	Maximum SMBus operating frequency.			400	kHz	5

¹ Guaranteed by design and characterization, not 100% tested in production.

² Control input must be monotonic from 20% to 80% of input swing.

³ Time from deassertion until outputs are > 200mV.

⁴ DIF_IN input.

⁵ The differential input clock must be running for the SMBus to be active.

Table 4. DIF_IN Clock Input Parameters

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units	Notes
Input Crossover Voltage	V_{CROSS}	Cross over voltage.	150		900	mV	1
Input Swing – DIF_IN	V_{SWING}	Differential value.	300			mV	1
Input Slew Rate – DIF_IN	dv/dt	Measured differentially.	0.35		8	V/ns	1,2
Input Leakage Current	I_{IN}	$V_{IN} = V_{DD}$, $V_{IN} = GND$.	-5		5	μA	
Input Duty Cycle	d_{tin}	Measurement from differential waveform.	45		55	%	1
Input Jitter –Cycle to Cycle	J_{DIFIn}	Differential measurement.	0		125	ps	1

¹ Guaranteed by design and characterization, not 100% tested in production.

² Slew rate measured through $\pm 75mV$ window centered around differential zero.

Table 5. Input/Supply/Common Parameters

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units	Notes
Supply Voltage	V_{DDX}	Supply voltage for core and analog.	3.135	3.3	3.465	V	
	V_{DDIO}	Supply voltage for differential outputs.	3.135	3.3	3.465	V	
Ambient Operating Temperature	T_{AMB}	Industrial range.	-40		85	$^{\circ}C$	
Input High Voltage	V_{IH}	Single-ended inputs, except SMBus, tri-level inputs.	2		$V_{DD} + 0.3$	V	
Input Low Voltage	V_{IL}	Single-ended inputs, except SMBus, tri-level inputs.	$GND - 0.3$		0.8	V	
Input High Voltage	V_{IH}	Tri-level inputs (“_tri” suffix).	2.2		$V_{DD} + 0.3$	V	
Input Mid Voltage	V_{IM}	Tri-level inputs (“_tri” suffix).	1.2	$V_{DD}/2$	1.8	V	
Input Low Voltage	V_{IL}	Tri-level inputs (“_tri” suffix).	$GND - 0.3$		0.8	V	
Input Current	I_{IN}	Single-ended inputs, $V_{IN} = GND$, $V_{IN} = V_{DDX}$.	-5		5	μA	
	I_{INP}	Single-ended inputs $V_{IN} = 0V$; Inputs with internal pull-up resistors. $V_{IN} = V_{DD}$; Inputs with internal pull-down resistors.	-100		100	μA	

Table 5. Input/Supply/Common Parameters (Cont.)

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units	Notes
Input Frequency	F_{IBYP}	$V_{DD} = 3.3V$, Bypass Mode.	1		400	MHz	
	F_{IPLL}	$V_{DD} = 3.3V$, 100MHz PLL Mode.	98.5	100.00	102	MHz	5
Pin Inductance	L_{pin}				7	nH	1
Capacitance	C_{IN}	Logic Inputs, except DIF_IN.	1.5		5	pF	1
	C_{INDIF_IN}	DIF_IN differential clock inputs.	1.5		2.7	pF	1,4
	C_{OUT}	Output pin capacitance.			6	pF	1
Clk Stabilization	t_{STAB}	From V_{DD} power-up and after input clock stabilization or deassertion of PD# to 1st clock.		1.2	1.8	ms	1,2
Input SS Modulation Frequency PCIe	$f_{MODINPCIe}$	Allowable frequency for PCIe applications (triangular modulation).	30	31.6	33	kHz	
OE# Latency	$t_{LATOE\#}$	DIF start after OE# assertion. DIF stop after OE# deassertion.	4	5	10	clocks	1,2,3
Tdrive_PD#	t_{DRVPD}	DIF output enable after PD# deassertion.		85	300	μs	1,3
Tfall	t_F	Fall time of control inputs.			5	ns	2
Trise	t_R	Rise time of control inputs.			5	ns	2

¹ Guaranteed by design and characterization, not 100% tested in production.

² Control input must be monotonic from 20% to 80% of input swing.

³ Time from deassertion until outputs are > 200mV, PLL Mode.

⁴ DIF_IN input.

⁵ This parameter reflects the operating range after locking to a 100MHz input.

Table 6. Current Consumption

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units	Notes
Operating Supply Current	I_{DDX}	All other V_{DD} pins, all outputs at 100MHz, $C_L = 2pF$; $Z_o = 85\Omega$.		22	30	mA	
	I_{DDA+R}	$V_{DDA} + V_{DDR}$ pins, all outputs at 100MHz, $C_L = 2pF$; $Z_o = 85\Omega$.		56	65	mA	1
	I_{DDO}	V_{DDIO} pins, all outputs at 100MHz, $C_L = 2pF$; $Z_o = 85\Omega$.		84	100	mA	
Power Down Current	I_{DDX}	All other V_{DD} pins, all outputs Low/Low.		0.9	2	mA	1
	I_{DDA+R}	$V_{DDA} + V_{DDR}$ pins, all outputs Low/Low.		4.3	6	mA	1
	I_{DDO}	V_{DDIO} pins, all outputs Low/Low.		0.1	0.2	mA	1

¹ Includes V_{DDR} if applicable.

Table 7. Skew and Differential Jitter Parameters

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units	Notes
CLK_IN, DIF[x:0]	$t_{\text{SKEW_PLL}}$	Input-to-output skew in PLL Mode at 100MHz, nominal temperature and voltage.	-100	-4	100	ps	1,2,4,5,6,8
CLK_IN, DIF[x:0]	$t_{\text{PD_BYP}}$	Input-to-output skew in Bypass Mode at 100MHz, nominal temperature and voltage.	2.2	2.9	3.6	ns	1,2,3,8
CLK_IN, DIF[x:0]	$t_{\text{DSPO_PLL}}$	Input-to-output skew variation in PLL Mode at 100MHz, across voltage and temperature.	-50	0.0	50	ps	1,2,3,8
CLK_IN, DIF[x:0]	$t_{\text{DSPO_BYP}}$	Input-to-output skew variation in Bypass Mode at 100MHz, across voltage and temperature, $T_{\text{AMB}} = 0$ to 70°C , default slew rate.	-250	0.0	250	ps	1,2,3,8
		Input-to-output skew variation in Bypass Mode at 100MHz, across voltage and temperature, $T_{\text{AMB}} = -40$ to 85°C , default slew rate.	-350	0.0	350	ps	1,2,3,8
DIF[x:0]	$t_{\text{SKEW_ALL}}$	Output-to-output skew across all outputs, common to PLL and Bypass Mode, at 100MHz, default slew rate.		30	50	ps	1,2,3,8
PLL Jitter Peaking	$j_{\text{peak-hibw}}$	LOBW#_BYPASS_HIBW = 1.	0	1.3	2.5	dB	7,8
PLL Jitter Peaking	$j_{\text{peak-lobw}}$	LOBW#_BYPASS_HIBW = 0.	0	1.3	2	dB	7,8
PLL Bandwidth	pll_{HIBW}	LOBW#_BYPASS_HIBW = 1.	2	2.6	4	MHz	8,9
PLL Bandwidth	pll_{LOBW}	LOBW#_BYPASS_HIBW = 0.	0.7	1.0	1.4	MHz	8,9
Duty Cycle	t_{DC}	Measured differentially, PLL Mode.	45	50	55	%	1
Duty Cycle Distortion	t_{DCD}	Measured differentially, Bypass Mode at 100MHz.	-1	-0.2	0	%	1,10
Jitter, Cycle to Cycle	$t_{\text{jyc-cyc}}$	PLL Mode.		13	50	ps	1,11
		Additive jitter in Bypass Mode.		0.2	5	ps	1,11

¹ Measured into fixed 2pF load cap. Input to output skew is measured at the first output edge following the corresponding input.

² Measured from differential cross-point to differential cross-point. This parameter can be tuned with external feedback path, if present.

³ All Bypass Mode input-to-output specs refer to the timing between an input edge and the specific output edge created by it.

⁴ This parameter is deterministic for a given device.

⁵ Measured with scope averaging on to find mean value.

⁶ This value is programmable.

⁷ Measured as maximum pass band gain. At frequencies within the loop BW, highest point of magnification is called PLL jitter peaking.

⁸ Guaranteed by design and characterization, not 100% tested in production.

⁹ Measured at 3db down or half power point.

¹⁰ Duty cycle distortion is the difference in duty cycle between the output and the input clock when the device is operated in Bypass Mode.

¹¹ Measured from differential waveform.

Table 8. DIF HCSL/LP-HCSL Outputs

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Industry Limits	Units	Notes
Slew Rate	dV/dt	Scope averaging on.	2.0	2.8	4.0	0.6 – 4.0	V/ns	1,2,3
Slew Rate Matching	Δ dV/dt	Slew rate matching, scope averaging on.		4	15	20	%	1,2,4,7
Maximum Voltage	V _{MAX}	Measurement on single-ended signal using absolute value (scope averaging off).	660	794	870	1150	mV	7,8
Minimum Voltage	V _{MIN}		-111	-49		-300		7,8
Crossing Voltage (abs)	V _{CROSS_ABS}	Scope averaging off.	302	367	453	250 – 550	mV	1,5,7
Crossing Voltage (var)	Δ -V _{CROSS}	Scope averaging off.		32	74	140	mV	1,6,7

¹ Guaranteed by design and characterization, not 100% tested in production.

² Measured from differential waveform.

³ Slew rate is measured through the V_{SWING} voltage range centered around differential 0 V. This results in a \pm 150mV window around differential 0V.

⁴ Matching applies to rising edge rate for Clock and falling edge rate for Clock#. It is measured using a \pm 75mV window centered on the average cross point where Clock rising meets Clock# falling. The median cross point is used to calculate the voltage thresholds the oscilloscope is to use for the edge rate calculations.

⁵ V_{CROSS} is defined as voltage where Clock = Clock# measured on a component test board and only applies to the differential rising edge (i.e. Clock rising and Clock# falling).

⁶ The total variation of all V_{CROSS} measurements in any particular system. Note that this is a subset of V_{CROSS_MIN/MAX} (V_{CROSS} absolute) allowed. The intent is to limit V_{CROSS} induced modulation by setting Δ -V_{CROSS} to be smaller than V_{CROSS} absolute.

⁷ At default SMBus settings.

⁸ If driving a receiver with input terminations, the V_{MAX} and V_{MIN} values will be halved.

Table 9. Filtered Phase Jitter Parameters - PCIe Common Clocked (CC) Architectures

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Industry Limits	Units	Notes
Phase Jitter, PLL Mode	t _{jphPCIeG1-CC}	PCIe Gen 1.		13	30	86	ps (p-p)	1, 2, 3, 6
	t _{jphPCIeG2-CC}	PCIe Gen 2 Low Band 10kHz < f < 1.5MHz (PLL BW of 5–16MHz or 8–16MHz, CDR = 5MHz).		0.25	0.7	3	ps (rms)	1, 2, 6
		PCIe Gen 2 High Band 1.5MHz < f < Nyquist (50MHz) (PLL BW of 5–16MHz or 8–16MHz, CDR = 5MHz).			1.00	1.5	3.1	ps (rms)
	t _{jphPCIeG3-CC}	PCIe Gen 3 (PLL BW of 2–4MHz or 2–5MHz, CDR = 10MHz).		0.24	0.35	1	ps (rms)	1, 2, 6
	t _{jphPCIeG4-CC}	PCIe Gen 4 (PLL BW of 2–4MHz or 2–5MHz, CDR = 10MHz).		0.24	0.35	0.5	ps (rms)	1, 2, 6

Table 9. Filtered Phase Jitter Parameters - PCIe Common Clocked (CC) Architectures (Cont.)

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Industry Limits	Units	Notes
Additive Phase Jitter, Bypass Mode	$t_{jphPCleG1-CC}$	PCIe Gen 1.		0.0	0.05	Not Applicable	ps (p-p)	1, 2, 3, 4, 6
	$t_{jphPCleG2-CC}$	PCIe Gen 2 Low Band 10kHz < f < 1.5MHz (PLL BW of 5–16MHz or 8–16MHz, CDR = 5MHz).		0.00	0.05		ps (rms)	1, 2, 3, 4, 6
		PCIe Gen 2 High Band 1.5MHz < f < Nyquist (50MHz) (PLL BW of 5–16MHz or 8–16MHz, CDR = 5MHz).		0.00	0.05		ps (rms)	1, 2, 3, 4, 6
	$t_{jphPCleG3-CC}$	PCIe Gen 3 (PLL BW of 2–4MHz or 2–5MHz, CDR = 10MHz).		0.00	0.05		ps (rms)	1, 2, 3, 4, 6
	$t_{jphPCleG4-CC}$	PCIe Gen 4 (PLL BW of 2–4MHz or 2–5MHz, CDR = 10MHz).		0.00	0.05		ps (rms)	1, 2, 3, 4, 6

Table 10. Filtered Phase Jitter Parameters - PCIe Independent Reference (IR) Architectures

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Industry Limits	Units	Notes
Phase Jitter, PLL Mode	$t_{jphPCleG2-SRIS}$	PCIe Gen 2 (PLL BW of 16MHz, CDR = 5MHz).		0.8	1.2	2	ps (rms)	1, 2, 5
	$t_{jphPCleG3-SRIS}$	PCIe Gen 3 (PLL BW of 2–4MHz, CDR = 10MHz).		0.64	0.68	0.7	ps (rms)	1, 2, 5
Additive Phase Jitter, Bypass Mode	$t_{jphPCleG2-SRIS}$	PCIe Gen 2 (PLL BW of 16MHz, CDR = 5MHz).		0.00	0.02	Not Applicable	ps (rms)	2, 4, 5
	$t_{jphPCleG3-SRIS}$	PCIe Gen 3 (PLL BW of 2–4MHz, CDR = 10MHz).		0.00	0.02		ps (rms)	2, 4, 5

Notes for PCIe Filtered Phase Jitter tables:

- ¹ Applies to all differential outputs when driven by 9SQL495x or equivalent, guaranteed by design and characterization.
- ² Calculated from Intel-supplied clock jitter tool, when driven by 9SQL495x or equivalent with spread on and off.
- ³ Sample size of at least 100K cycles. This figure extrapolates to 108ps pk-pk at 1M cycles for a BER of 1^{-12} .
- ⁴ For RMS values, additive jitter is calculated by solving the following equation for b [$b = \sqrt{c^2 - a^2}$] where “a” is rms input jitter and “c” is rms total jitter.
- ⁵ IR is the new name for Separate Reference Independent Spread (SRIS) and Separate Reference no Spread (SRNS) PCIe clock architectures. According to the PCIe Base Specification Rev4.0 version 0.7 draft, the jitter transfer functions and corresponding jitter limits are not defined for the IR clock architecture. Widely accepted industry limits using widely accepted industry filters are used to populate this table. There are no accepted filters or limits for IR clock architectures at PCIe Gen1 or Gen4 data rates.

Table 11. Filtered Phase Jitter Parameters – QPI/UPI

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Industry Limits	Units	Notes
Phase Jitter, PLL Mode	t _{jphQPI_UPI}	QPI & UPI (100MHz or 133MHz, 4.8Gb/s, 6.4Gb/s 12UI).		0.15	0.3	0.5	ps (rms)	1, 2
		QPI & UPI (100MHz, 8.0Gb/s, 12UI).		0.08	0.1	0.3	ps (rms)	1, 2
		QPI & UPI (100MHz, ≥ 9.6Gb/s, 12UI).		0.07	0.1	0.2	ps (rms)	1, 2
	t _{jphIF-UPI}	IF-UPI.		0.1 0.17	0.15 0.2	1	ps (rms)	1, 4, 5
Additive Phase Jitter, Bypass Mode	t _{jphQPI_UPI}	QPI & UPI (100MHz or 133MHz, 4.8Gb/s, 6.4Gb/s 12UI).		0.00	0.03	Not Applicable	ps (rms)	1, 2, 3
		QPI & UPI (100MHz, 8.0Gb/s, 12UI).		0.02	0.07		ps (rms)	1, 2, 3
		QPI & UPI (100MHz, ≥ 9.6Gb/s, 12UI).		0.02	0.06		ps (rms)	1, 2, 3
	t _{jphIF-UPI}	IF-UPI.		0.06	0.08		ps (rms)	1, 4

¹ Applies to all differential outputs, guaranteed by design and characterization.

² Calculated from Intel-supplied clock jitter tool, when driven by 9SQL495x or equivalent with spread on and off.

³ Additive jitter for RMS values is calculated by solving for b [$b = \sqrt{c^2 - a^2}$] where “a” is rms input jitter and “c” is rms total jitter.

⁴ Calculated from phase noise analyzer when driven by Wenzel Associates source with Intel-specified brick-wall filter applied.

⁵ Top number is when the buffer is in Low BW mode, bottom number is when the buffer is in High BW mode.

Table 12. Unfiltered Phase Jitter Parameters – 12kHz to 20MHz

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Industry Limits	Units	Notes
Phase Jitter, PLL Mode	t _{jph12k-20MHi}	PLL High BW, SSC Off, 100MHz.		171	250	Not applicable	fs (rms)	1,2
Phase Jitter, PLL Mode	t _{jph12k-20MLo}	PLL Low BW, SSC Off, 100MHz.		183	250		fs (rms)	1,2
Additive Phase Jitter, Bypass Mode	t _{jph12k-20MBy}	Bypass Mode, SSC Off, 100MHz.		109	150		fs (rms)	1,2,3

¹ Applies to all outputs when driven by Wenzel clock source.

² 12kHz to 20MHz brick wall filter.

³ For RMS values, additive jitter is calculated by solving for b [$a^2 + b^2 = c^2$] where “a” is rms input jitter and “c” is rms total jitter.

Power Management

Inputs		Control Bits	Outputs		PLL State
CKPWRGD_PD#	DIF_IN	SMBus EN bit	DIF_x	FBOUT_NC	
0	X	X	Low/Low	Low/Low	Off
1	Running	0	Low/Low	Running	On
		1	Running	Running	On

Power Connections (9ZML12xxE)

Pin Number			Description
V _{DD}	V _{DDIO}	GND	
1		2	Analog PLL
9		8	Analog input
28, 45, 64	40, 52	22, 27, 34, 39, 46, 51, 58, 63, 70	DIF clocks

Power Connections (for pin-compatibility with 9ZML12xxB)

Pin Number			Description
V _{DD}	V _{DDIO}	GND	
1		2	Analog PLL
9		8	Analog input
28, 45, 64	21, 33, 40, 52, 57, 69	16, 22, 27, 34, 39, 46, 51, 58, 63, 70	DIF clocks

PLL Operating Mode

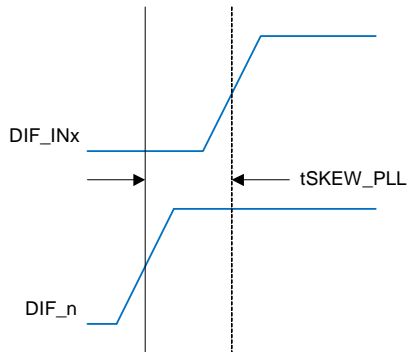
HIBW_BYPM_LOBW#	Byte0[7:6]
Low (PLL Low BW)	00
Mid (Bypass)	01
High (PLL High BW)	11

Note: PLL is off in Bypass Mode.

Skew Programming

Skew[2:0]	Skew Steps	Skew (ps)
000	0	0
001	1	-416.67
010	2	-833.33
011	3	-1250.00
100	4	-1666.67
101	5	-2083.33
110	6	-2500.00
111	7	-2916.67

Figure 1. Skew Diagram



Test Loads

Low-Power HCSL Output Test Load
(standard PCIe source-terminated test load)

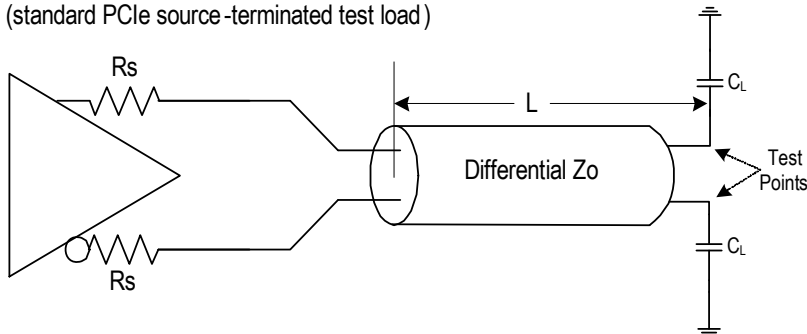


Table 13. Parameters for Low-Power HCSL Output Test Load

Device	R_s (Ω)	Z_o (Ω)	L (inches)	C_L (pF)
9ZML123x	27	85	12	2
9ZML123x	33	100	12	2
9ZML125x *	Internal	85	12	2
9ZML125x *	7.5	100	12	2

* Contact factory for versions of this device with $Z_o=100\Omega$.

Alternate Terminations

The LP-HCSL can easily drive other logic families. See [“AN-891 Driving LVPECL, LVDS, and CML Logic with IDT’s “Universal” Low-Power HCSL Outputs”](#) for details.

Clock Periods

Table 14. Clock Periods – Differential Outputs with Spread Spectrum Disabled

SSC On	Center Frequency MHz	Measurement Window							Units	Notes
		1 Clock	1µs	0.1s	0.1s	0.1s	1µs	1 Clock		
		-c2jitter AbsPer Minimum	-SSC Short-Term Average Minimum	-ppm Long-Term Average Minimum	0 ppm Period Nominal	+ppm Long-Term Average Maximum	+SSC Short-Term Average Maximum	+c2jitter AbsPer Maximum		
DIF	100.00	9.94900	—	9.99900	10.00000	10.00100	—	10.05100	ns	1,2,3

Table 15. Clock Periods – Differential Outputs with Spread Spectrum Enabled

SSC On	Center Frequency MHz	Measurement Window							Units	Notes
		1 Clock	1µs	0.1s	0.1s	0.1s	1µs	1 Clock		
		-c2jitter AbsPer Minimum	-SSC Short-Term Average Minimum	-ppm Long-Term Average Minimum	0 ppm Period Nominal	+ppm Long-Term Average Maximum	+SSC Short-Term Average Maximum	+c2jitter AbsPer Maximum		
DIF	99.75	9.94906	9.99906	10.02406	10.02506	10.02607	10.05107	10.10107	ns	1,2,3

¹ Guaranteed by design and characterization, not 100% tested in production.

² All Long Term Accuracy specifications are guaranteed with the assumption that the input clock complies with CK420BQ accuracy requirements (+/-100ppm). The buffer itself does not contribute to ppm error.

³ Driven by SRC output of main clock, 100MHz PLL Mode or Bypass Mode.

General SMBus Serial Interface Information

How to Write

- Controller (host) sends a start bit
- Controller (host) sends the write address
- IDT clock will **acknowledge**
- Controller (host) sends the beginning byte location = N
- IDT clock will **acknowledge**
- Controller (host) sends the byte count = X
- IDT clock will **acknowledge**
- Controller (host) starts sending Byte N through Byte N+X-1
- IDT clock will **acknowledge** each byte **one at a time**
- Controller (host) sends a stop bit

Index Block Write Operation		
Controller (Host)		IDT (Slave/Receiver)
T	starT bit	
Slave Address		
WR	WRite	
Beginning Byte = N		ACK
		ACK
Data Byte Count = X		ACK
Beginning Byte N		ACK
O	X Byte	O
O		O
O		O
Byte N + X - 1		
		ACK
P	stoP bit	

9ZML1233E / 9ZML1253E SMBus Addressing

SMB_A0_tri	SMBus Address (Read/Write bit = 0)
0	D8
M	DA
1	DE

How to Read

- Controller (host) will send a start bit
- Controller (host) sends the write address
- IDT clock will **acknowledge**
- Controller (host) sends the beginning byte location = N
- IDT clock will **acknowledge**
- Controller (host) will send a separate start bit
- Controller (host) sends the read address
- IDT clock will **acknowledge**
- IDT clock will send the data byte count = X
- IDT clock sends Byte N+X-1
- IDT clock sends **Byte 0 through Byte X (if X_(H) was written to Byte 8)**
- Controller (host) will need to acknowledge each byte
- Controller (host) will send a not acknowledge bit
- Controller (host) will send a stop bit

Index Block Read Operation		
Controller (Host)		IDT (Slave/Receiver)
T	starT bit	
Slave Address		
WR	WRite	
Beginning Byte = N		ACK
		ACK
RT	Repeat starT	
Slave Address		
RD	ReaD	
		ACK
		Data Byte Count=X
ACK		Beginning Byte N
ACK		O
O		O
O		O
O		
		Byte N + X - 1
N	Not acknowledge	
P	stoP bit	

SMBus Table: PLL Mode and Frequency Select Register

Byte 0	Name	Control Function	Type	0	1	Default
Bit 7	PLL Mode bit [1]	PLL Operating Mode Rd back 1	R	See PLL Operating Mode table		Latch
Bit 6	PLL Mode bit [0]	PLL Operating Mode Rd back 0	R			Latch
Bit 5	SEL_A_B#	Input Select Readback	R	DIF_INB	DIF_INA	Real
Bit 4	Reserved					0
Bit 3	PLL_InSEL_SW_EN	Enable S/W control of PLL BW and Input select	RW	Pin Control	SMBus Control	0
Bit 2	PLL Mode bit [1]	PLL Operating Mode 1	RW	See PLL Operating Mode table ¹		1
Bit 1	PLL Mode bit [0]	PLL Operating Mode 1	RW			1
Bit 0	Reserved					1

Note: Changing the PLL operating mode between HiBW or LoBW and Bypass mode or between Bypass mode and HiBW or LoBW requires a system reset. Changing the PLL operating mode between HiBW and LoBW or between LoBW and HiBW does not require a system reset.

SMBus Table: Output Disable Register

Byte 1	Name	Control Function	Type	0	1	Default
Bit 7	DIF_7_En	Output Control overrides OE# pin	RW	Low/Low	Pin Control	1
Bit 6	DIF_6_En	Output Control overrides OE# pin	RW			1
Bit 5	DIF_5_En	Output Control overrides OE# pin	RW			1
Bit 4	DIF_4_En	Output Control overrides OE# pin	RW			1
Bit 3	DIF_3_En	Output Control overrides OE# pin	RW			1
Bit 2	DIF_2_En	Output Control overrides OE# pin	RW			1
Bit 1	DIF_1_En	Output Control overrides OE# pin	RW			1
Bit 0	DIF_0_En	Output Control overrides OE# pin	RW			1

SMBus Table: Output Control Register

Byte 2	Name	Control Function	Type	0	1	Default
Bit 7	Reserved					0
Bit 6	Reserved					0
Bit 5	Reserved					0
Bit 4	Reserved					0
Bit 3	DIF_11_En	Output Control overrides OE# pin	RW	Low/Low	Pin Control	1
Bit 2	DIF_10_En	Output Control overrides OE# pin	RW			1
Bit 1	DIF_9_En	Output Control overrides OE# pin	RW			1
Bit 0	DIF_8_En	Output Control overrides OE# pin	RW			1

SMBus Table: Reserved Register

Byte 3	Name	Control Function	Type	0	1	Default
Bit 7		Reserved				0
Bit 6		Reserved				0
Bit 5		Reserved				0
Bit 4		Reserved				0
Bit 3		Reserved				0
Bit 2		Reserved				0
Bit 1		Reserved				0
Bit 0		Reserved				0

SMBus Table: Reserved Register

Byte 4	Name	Control Function	Type	0	1	Default
Bit 7		Reserved				0
Bit 6		Reserved				0
Bit 5		Reserved				0
Bit 4		Reserved				0
Bit 3		Reserved				0
Bit 2		Reserved				0
Bit 1		Reserved				0
Bit 0		Reserved				0

SMBus Table: Vendor & Revision ID Register

Byte 5	Name	Control Function	Type	0	1	Default
Bit 7	RID3	REVISION ID	R	E rev = 0100		0
Bit 6	RID2		R			1
Bit 5	RID1		R			0
Bit 4	RID0		R			0
Bit 3	VID3	VENDOR ID	R	—	—	0
Bit 2	VID2		R	—	—	0
Bit 1	VID1		R	—	—	0
Bit 0	VID0		R	—	—	1

SMBus Table: Device ID

Byte 6	Name	Control Function	Type	0	1	Default
Bit 7	Device ID 7 (MSB)		R	9ZML1233=ED 9ZML1253=FD		1
Bit 6	Device ID 6		R			1
Bit 5	Device ID 5		R			1
Bit 4	Device ID 4		R			X
Bit 3	Device ID 3		R			1
Bit 2	Device ID 2		R			1
Bit 1	Device ID 1		R			0
Bit 0	Device ID 0		R			X

SMBus Table: Byte Count Register

Byte 7	Name	Control Function	Type	0	1	Default
Bit 7	Reserved					0
Bit 6	Reserved					0
Bit 5	Reserved					0
Bit 4	BC4	Writing to this register configures how many bytes will be read back.	RW	Default value is 8 hex, so 9 bytes (0 to 8) will be read back by default.		0
Bit 3	BC3		RW			1
Bit 2	BC2		RW			0
Bit 1	BC1		RW			0
Bit 0	BC0		RW			0

SMBus Table: Output Skew Register A (when Input Clock A is selected)

Byte 8	Name	Control Function	Type	0	1	Default
Bit 7	Reserved					0
Bit 6	Reserved					0
Bit 5	Reserved					0
Bit 4	Reserved					0
Bit 3	Reserved					0
Bit 2	I2O_FB_ASkew2	Channel A Output delay programming (early)	RW	Binary value of number of VCO periods that outputs will be pulled earlier than input.		0
Bit 1	I2O_FB_ASkew1		RW			0
Bit 0	I2O_FB_ASkew0		RW			0

Note: For example, at 2.4GHz, each VCO period is 416.7ps and there are 24 VCO periods in a 100MHz output. Each write to bits [2:0] will pull the output a early by that number of VCO periods. Writing "110" 4 times would pull the output back in phase with the input. Writing "001" twice will accomplish the same result as writing "010" once - pulling the output 2 VCO periods earlier.

SMBus Table: Output Skew Register A (when Input Clock B is selected)

Byte 9	Name	Control Function	Type	0	1	Default
Bit 7	Reserved					0
Bit 6	Reserved					0
Bit 5	Reserved					0
Bit 4	Reserved					0
Bit 3	Reserved					0
Bit 2	I2O_FB_BSkew2	Channel B Output delay programming (early)	RW	Binary value of number of VCO periods that outputs will be earlier than input. Default is 0.		0
Bit 1	I2O_FB_BSkew1		RW			0
Bit 0	I2O_FB_BSkew0		RW			0

Note: For example, at 2.4GHz, each VCO period is 416.7ps and there are 24 VCO periods in a 100MHz output. Each write to bits [2:0] will pull the output a early by that number of VCO periods. Writing “110” 4 times would pull the output back in phase with the input. Writing “001” twice will accomplish the same result as writing “010” once - pulling the output 2 VCO periods earlier.

Package Outline Drawings

The package outline drawings are appended at the end of this document and are accessible from the link below. The package information is the most current data available.

www.idt.com/document/psc/nlnlg72-package-outline-100-x-100-mm-body-epad-59-mm-sq-050-mm-pitch-vfqfn-sawn

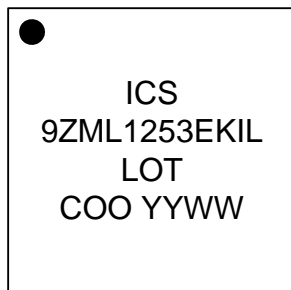
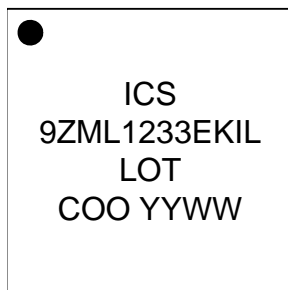
Ordering Information

Orderable Part Number	Package	Carrier Type	Temperature
9ZML1233EKILF	10 x 10 mm, 0.5mm pitch 72-VFQFPN	Tray	-40° to +85°C
9ZML1233EKILFT	10 x 10 mm, 0.5mm pitch 72-VFQFPN	Tape and Reel	-40° to +85°C
9ZML1253EKILF	10 x 10 mm, 0.5mm pitch 72-VFQFPN	Tray	-40° to +85°C
9ZML1253EKILFT	10 x 10 mm, 0.5mm pitch 72-VFQFPN	Tape and Reel	-40° to +85°C

“LF” designates PB-free configuration, RoHS compliant.

“E” is the device revision designator (will not correlate with the datasheet revision).

Marking Diagrams



1. “L” denotes RoHS compliant package.
2. “LOT” denotes the lot number.
3. “COO” denotes country of origin.
4. “YYWW” denotes the last two digits of the year and week the part was assembled.

Revision History

Revision Date	Description of Change
April 12, 2018	Updated absolute maximum supply voltage rating and VIHSMB to 3.9V.
December 1, 2017	Removed "5V tolerant" reference in pins 13 and 14 descriptions.
May 19, 2017	Corrected typos in orderable part numbers.
May 11, 2017	<ul style="list-style-type: none"> ▪ Updated package outline drawings to latest version. ▪ Updated Byte 6 IDs.
April 27, 2017	<ul style="list-style-type: none"> ▪ Updated Phase Jitter, PLL Mode IF-UPI typical and maximum values.
April 21, 2017	<ul style="list-style-type: none"> ▪ Update Features and Key Specifications. ▪ Updated PCIe Common Clocked, PCIe Separate Clocked, and QPI/UPI to latest format, added IF-UPI spec to QPI/UPI tables. ▪ Updated Test Loads drawing to latest version. ▪ Corrected SMBus Addressing table for 1233/1253.
April 11, 2017	<ul style="list-style-type: none"> ▪ Reverted back to original Device ID Scheme, byte 6 updated accordingly: 9ZML1233=ED 9ZML1253=FD
January 31, 2017	Initial release.



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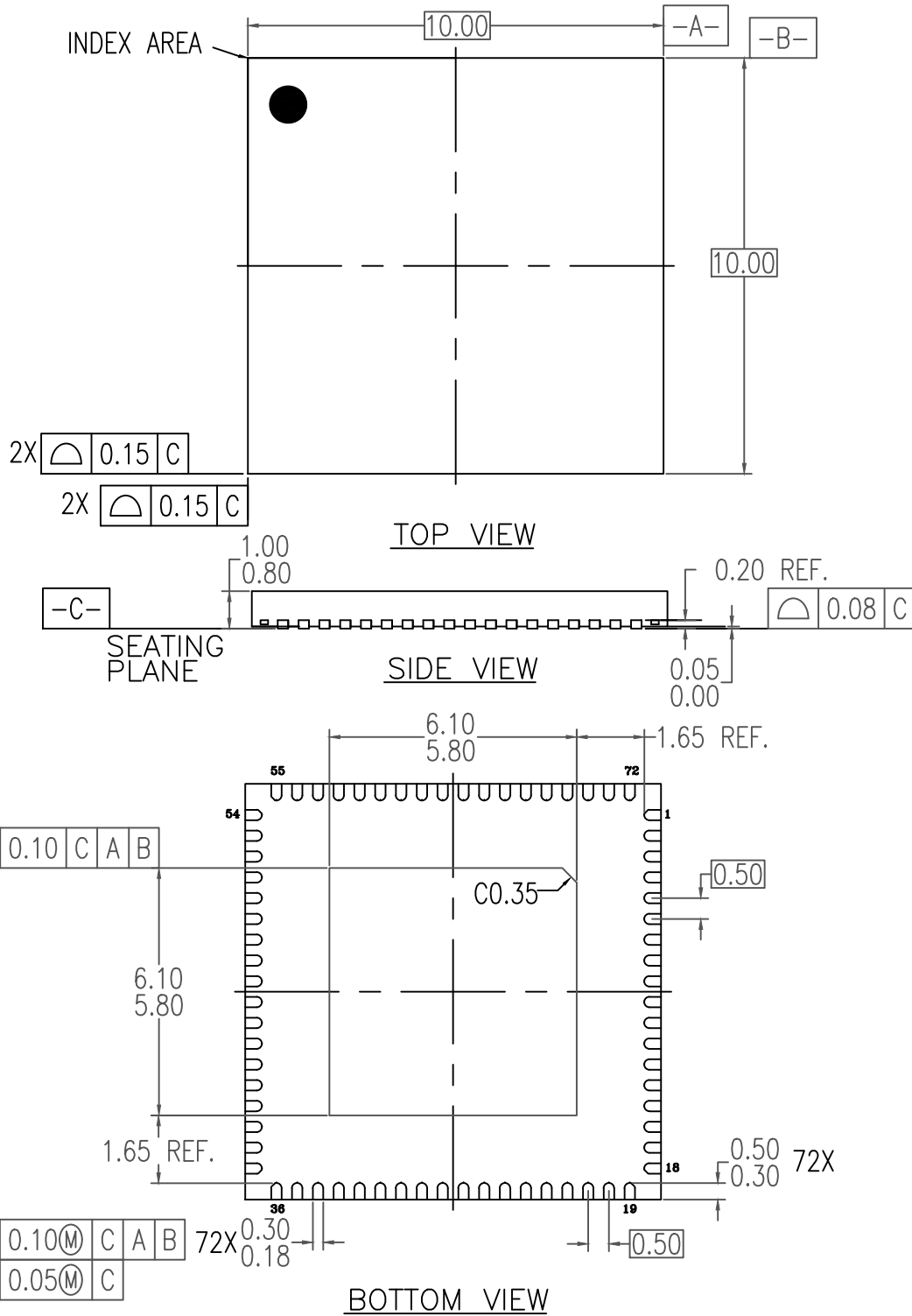
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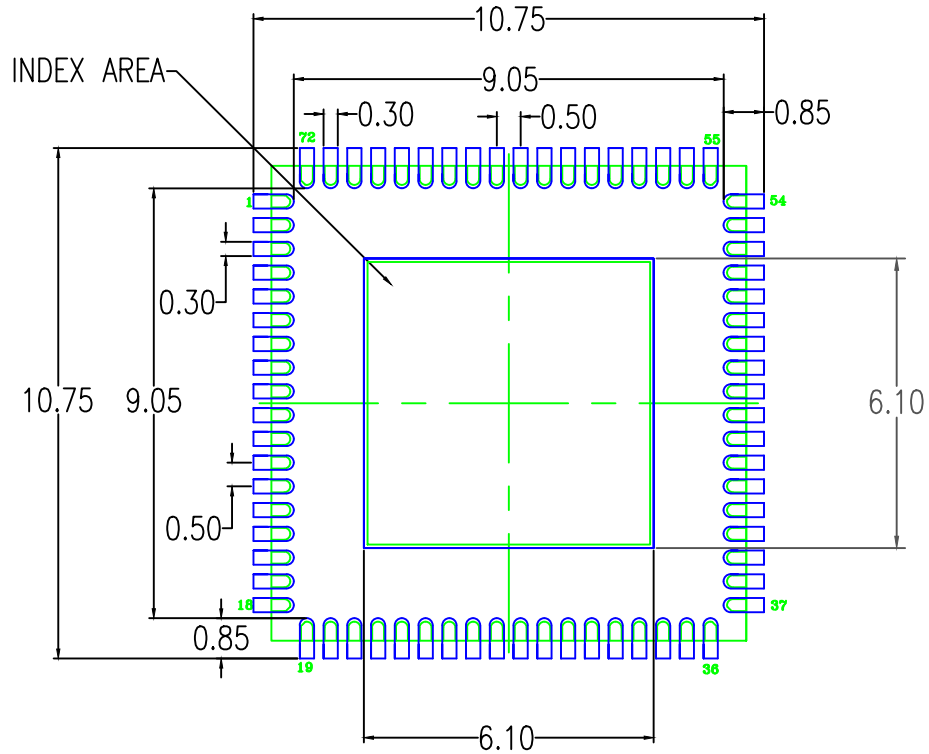
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NOTES:

1. ALL DIMENSIONING AND TOLERANCING CONFORM TO ANSI Y14.5M-1994
2. ALL DIMENSIONS ARE IN MILLIMETERS.
3. INDEX AREA (PIN1 IDENTIFIER)



RECOMMENDED LAND PATTERN DIMENSION

NOTES:

1. ALL DIMENSIONS ARE IN MM. ANGLES IN DEGREES.
2. TOP DOWN VIEW. AS VIEWED ON PCB.
3. COMPONENT OUTLINE SHOWS FOR REFERENCE IN GREEN.
4. LAND PATTERN IN BLUE. NSMD PATTERN ASSUMED.
5. LAND PATTERN RECOMMENDATION PER IPC-7351B GENERIC REQUIREMENT FOR SURFACE MOUNT DESIGN AND LAND PATTERN.

Package Revision History		
Date Created	Rev No.	Description
Sept 3, 2019	Rev 03	Update P1 Dimension from 5.8 to 5.95 mm SQ
May 8, 2017	Rev 02	Change Package Code QFN to VFQFPN

Компания «Life Electronics» занимается поставками электронных компонентов импортного и отечественного производства от производителей и со складов крупных дистрибьюторов Европы, Америки и Азии.

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- Специальные условия для постоянных клиентов.
- Подбор аналогов.
- Поставку компонентов в любых объемах, удовлетворяющих вашим потребностям.
- Приемлемые сроки поставки, возможна ускоренная поставка.
- Доставку товара в любую точку России и стран СНГ.
- Комплексную поставку.
- Работу по проектам и поставку образцов.
- Формирование склада под заказчика.
- Сертификаты соответствия на поставляемую продукцию (по желанию клиента).
- Тестирование поставляемой продукции.
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- Регистрацию проекта у производителя компонентов.
- Техническую поддержку проекта.
- Защиту от снятия компонента с производства.
- Оценку стоимости проекта по компонентам.
- Изготовление тестовой платы монтаж и пусконаладочные работы.



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